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| Notice of References Cited | Application/Control No. 10/804,909 | Applicant(s)/Patent Under Reexamination SATTLER, STEPHAN | |
| | Examiner Imran Akram | Art Unit 1709 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-5,372,264 | 12-1994 | Rudi et al. | 211/41.12 |
| * | B | US-4,840,771 | 06-1989 | Williamson et al. | 422/104 |
| * | C | US-4,773,976 | 09-1988 | Vexler, Gavriel L. | 156/51 |
| * | D | US-4,988,006 | 01-1991 | Lundin, David J. | 211/46 |
| * | E | US-5,855,851 | 01-1999 | Matsubara et al. | 422/100 |
| * | F | US-5,270,210 | 12-1993 | Weyrauch et al. | 436/43 |
| * | G | US-6,268,596 b1 | 07-2001 | Lauf et al. | 219/687 |
| * | H | US-5,512,247 | 04-1996 | Bonacina et al. | 422/67 |
| * | I | US-6,107,810 | 08-2000 | Ishizawa et al. | 324/662 |
| * | J | US-2004/0171163 | 09-2004 | Lopez et al. | 436/063 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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